Se	earch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/785,211	LOFTHUS ET AL.
Examiner	Art Unit

Patrick H. Mackey

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	SEARCHED			
Class	Subclass	Date	Examiner	
271	9.01			
	9.12			
	9.13			
	184		i	
	185			
	279	6/24/2005	РНМ	
Above	Updated	10/21/2005	РНМ	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			
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(INCLUDING S	RCH NOT)
	_	DATE	EXMR
Text Search		6/24/2005	РНМ
Plus Search		6/24/2005	РНМ
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